

Docket No.: P2001,0356

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : TORSTEN SEIDEL ET AL.  
Filed : CONCURRENTLY HEREWITH  
Title : CONFIGURATION AND METHOD FOR DETECTING DEFECTS  
ON A SUBSTRATE IN A PROCESSING TOOL

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

U.S. Patent No. 6,200,823 B1 (Steffan et al.), dated March 13, 2001;

U.S. Patent No. 6,047,083 (Mizuno), dated April 4, 2000;

U.S. Patent No. 5,949,901 (Nichani et al.), dated September 7, 1999;

U.S. Patent No. 6,169,282 B1 (Maeda et al.), dated January 2, 2001;

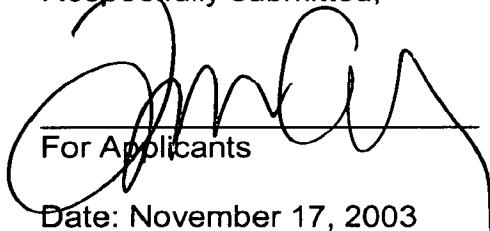
Published European Patent Application No. 0 444 450 A1 (Hopewell et al.), dated September 4, 1991 and

Published International Application No. 98/44330 (Kinney et al.), dated October 8, 1998.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /BL/

If no translation of pertinent portions of any foreign language patents or publications mentioned above is included with the aforementioned copies of those applications, patents and/or publications, it is because no existing translation is readily available to the applicant. As per the Notice in 1273 OG 55 (August 5, 2003) no copies of any above-mentioned U.S. patents and U.S. patent application publications are submitted for any application filed after June 30, 2003..

Respectfully submitted,

  
For Applicants

**LAURENCE A. GREENBERG**  
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Date: November 17, 2003

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<b>FORM PTO-1449 (SUBSTITUTE)</b>  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  <b>INFORMATION DISCLOSURE          STATEMENT BY APPLICANT</b> (37 CFR 1.98(b))				Attorney Docket No.: P2001,0356 Appl. No.: _____  Applicant: TORSTEN SEIDEL ET AL.  Filing Date: November 17, 2003 Group Art Unit: _____			
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EXAMINER INITIALS	PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A	6,200,823 B1	03/01	Steffan et al.		
	B	6,047,083	04/00	Mizuno		
	C	5,949,901	09/99	Nichani et al.		
	D	6,169,282 B1	01/01	Maeda et al.		
	E					
	F					
	G					
	H					
	I					

FOREIGN PATENT DOCUMENT							
DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES   NO		
J	0444450 A1	09/91	Europe				
K	98/44330	10/98	International				
L							
M							
N							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)		

EXAMINER                      /Brian Le/	DATE CONSIDERED 06/24/2008
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.
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